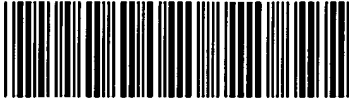


Search Notes

Application/Control No.

10/023,737

Examiner

Steven HD Nguyen

Applicant(s)/Patent under
Reexamination

MASUI ET AL.

Art Unit

2665

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See East search history	12/5/2005	ST
IEEE, busy tone, admission control	12/5/2005	ST